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# Solving multi-response optimization problem using artificia network and PCR-VIKOR

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## ABSTRACT

In this paper a hybrid approach is introduced to solve multiple response problems. In the propose to noise (SN) ratio is computed and then SN ratios for unexperimented treatments are estimated neural network. The SN ratios are converted into a process performance index by applying proces and VIKOR method, so the treatments can be ranked and the best of them is selected. The perfor proposed method is verified in a case study. Moreover a sensitivity analysis has been done by a V estimator turned neural network. The results show efficiency of the proposed approach.

## **INDEX TERMS**

#### • IEEE Terms

Artificial neural networks , Biological neural networks , Equations , Indexes , Optimization , Sensitivity

## • INSPEC

#### • Controlled Indexing

mathematics computing , neural nets , optimisation , sensitivity analysis

## Non Controlled Indexing

PCR-VIKOR, VIKOR score estimator turned neural network, VIse Kriterijumska Optimizacija I Kom method, artificial neural network, hybrid approach, multiresponse optimization problem, process process performance index, sensitivity analysis, signal to noise ratio

## • Author Keywords

Taguchi , VIKOR method , artificial neural network , multiresponse optimization , process capability ra

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